

Date: 2015-09-21

Report Number: 60.790.15.028.01

Model No.: HSTNW-D01W

## Radiofrequency radiation exposure evaluation

According to KDB 447498 D01v05r02 section 4.3.1,

>> The 1-g SAR test exclusion thresholds, for 100MHz to 6GHz, at test separation distances ≤ 50 mm are determined by:

Power at 2402GHz = 0.0453 mW EIRP Power at 2440GHz = 0.0459 mW EIRP Power at 2480GHz = 0.0485 mW EIRP

 $[(0.0453 \text{ mW}) / (50 \text{ mm})] \cdot [\text{sqrt} (2402 \text{ GHz})] = 0.0444 \text{ which is } \le 3.0 \text{ for } 1\text{-g SAR}.$   $[(0.0459 \text{ mW}) / (50 \text{ mm})] \cdot [\text{sqrt} (2440 \text{ GHz})] = 0.0453 \text{ which is } \le 3.0 \text{ for } 1\text{-g SAR}.$   $[(0.0485 \text{ mW}) / (50 \text{ mm})] \cdot [\text{sqrt} (2480 \text{ GHz})] = 0.0483 \text{ which is } \le 3.0 \text{ for } 1\text{-g SAR}.$ 

Therefore the device is exempt from stand-alone SAR test requirements.

- >> The fundamental frequency of the EUT is 2402MHz-2480MHz, the test separation distance is < 50mm.
- >> The power of EUT measured is:
  - For 2402MHz: 0.0453mW = 10 log (0.0453) dBm ~ -13.43dBm
  - For 2440MHz: 0.0459mW = 10 log (0.0459) dBm ~ -13.38dBm
  - For 2480MHz: 0.0485mW = 10 log (0.0485) dBm ~ -13.14dBm

Page 1 of 1
TÜV SÜD Hong Kong Ltd.
3/F, West Wing, Phase 2, 10 Science Park West Avenue, Hong Kong Science Park, Shatin, Hong Kong